

Notice of References Cited	Application/Control No. 10/830,198		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Charles Shedrick		Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0085944 A1	05-2004	Boehm, Lawrence D.	370/338
*	C	US-6,570,884	05-2003	Connery et al.	370/419
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